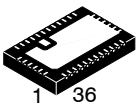
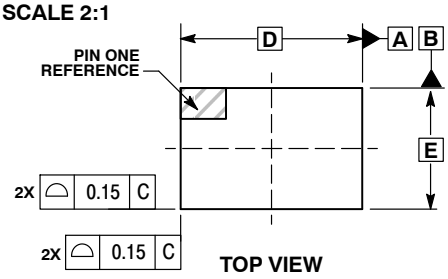
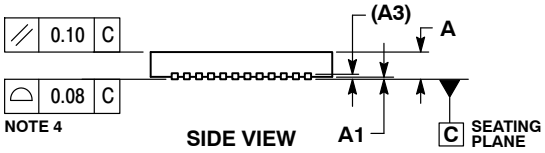
QFN36 6x4, 0.4P
CASE 485DZ
ISSUE A

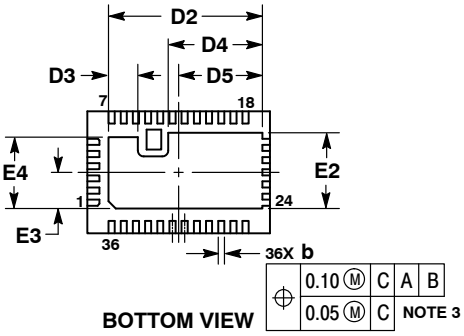
DATE 19 JUN 2015

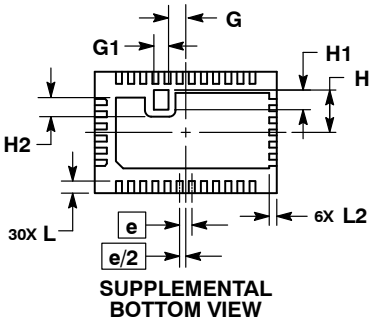


SCALE 2:1





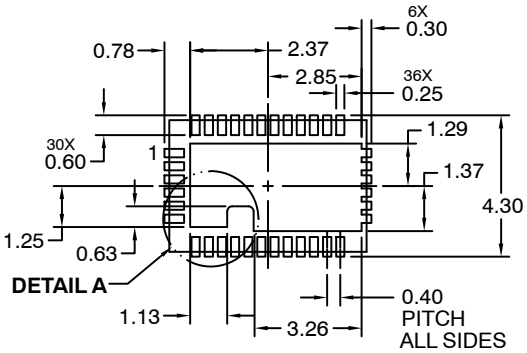


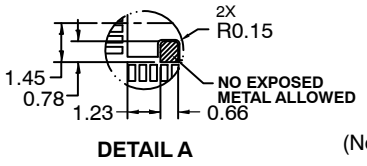


NOTES:
1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
2. CONTROLLING DIMENSION: MILLIMETERS.
3. DIMENSION b APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.15 AND 0.25 MM FROM THE TERMINAL TIP.
4. COPLANARITY APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS.

	MILLIMETERS	
DIM	MIN	MAX
A	0.90	1.20
A1	0.00	0.05
A3	0.20 REF	
b	0.15	0.25
D	6.00 BSC	
D2	4.95	5.05
D3	0.91	1.01
D4	3.04	3.14
D5	2.70	2.80
E	4.00 BSC	
E2	2.44	2.54
E3	1.14	1.24
E4	2.29	2.39
e	0.40 BSC	
G	0.52	0.62
G1	0.43	0.53
H	1.35	1.45
H1	0.60	0.70
H2	0.57	0.68
L	0.30	0.50
L2	0.15	0.35

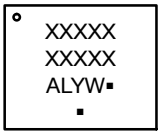
RECOMMENDED SOLDERING FOOTPRINT*





*For additional information on our Pb−Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

GENERIC MARKING DIAGRAM*



A = Assembly Location
L = Wafer Lot
Y = Year
W = Work Week
▪ = Pb−Free Package

(Note: Microdot may be in either location)

*This information is generic. Please refer to device data sheet for actual part marking. Pb−Free indicator, “G” or microdot “ ▪”, may or may not be present.

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DESCRIPTION:	**QFN36 6X4, 0.4P**		**PAGE 1 OF 1**